

NPN POWER SILICON SWITCHING TRANSISTOR

Qualified per MIL-PRF-19500/560

DEVICES

2N5339 2N5339U3

LEVELS

**JAN
 JANTX
 JANTXV
 JANS**

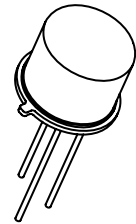
ABSOLUTE MAXIMUM RATINGS ($T_C = +25^\circ\text{C}$ unless otherwise noted)

Parameters / Test Conditions	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	100	Vdc
Collector-Base Voltage	V_{CBO}	100	Vdc
Emitter-Base Voltage	V_{EBO}	6.0	Vdc
Base Current	I_B	1.0	Adc
Collector Current	I_C	5.0	Adc
Total Power Dissipation	P_T	@ $T_A = +25^\circ\text{C}$ ⁽¹⁾	1.0
		@ $T_C = +25^\circ\text{C}$ ⁽²⁾	17.5
		@ $T_C = +25^\circ\text{C}$ ⁽³⁾ – U3	75
Operating & Storage Junction Temperature Range	T_{op}, T_{stg}	-65 to +200	$^\circ\text{C}$
Thermal Resistance, Junction-to Air	$R_{\theta JA}$	175	$^\circ\text{C/W}$

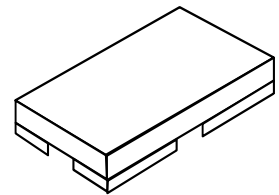
- 1) Derate linearly 5.71mW/ $^\circ\text{C}$ for $T_A > 25^\circ\text{C}$
- 2) Derate linearly 100mW/ $^\circ\text{C}$ for $T_C > 25^\circ\text{C}$
- 3) Derate linearly 434mW/ $^\circ\text{C}$ for $T_C > 25^\circ\text{C} - U3$

ELECTRICAL CHARACTERISTICS ($T_A = +25^\circ\text{C}$, unless otherwise noted)

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage $I_C = 50\text{mA}$	$V_{(BR)CEO}$	100		Vdc
Collector-Emitter Cutoff Current $V_{CE} = 100\text{Vdc}$	I_{CEO}		100	μAdc
Collector-Emitter Cutoff Current $V_{CE} = 90\text{Vdc}, V_{BE} = 1.5\text{Vdc}$	I_{CEX}		1.0	μAdc
Collector-Base Cutoff Current $V_{CB} = 100\text{Vdc}$	I_{CBO}		1.0	μAdc
Emitter-Base Cutoff Current $V_{EB} = 6.0\text{Vdc}$	I_{EBO}		100	μAdc



**TO-39
(TO-205AD)**



**U-3
(TO-276AA)**

NPN POWER SILICON SWITCHING TRANSISTOR

Qualified per MIL-PRF-19500/560

ELECTRICAL CHARACTERISTICS ($T_A = +25^\circ\text{C}$, unless otherwise noted) (CONT.)

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
ON CHARACTERISTICS ⁽³⁾				
Forward-Current Transfer Ratio $I_C = 0.5\text{A}_{dc}$, $V_{CE} = 2.0\text{V}_{dc}$ $I_C = 2.0\text{A}_{dc}$, $V_{CE} = 2.0\text{V}_{dc}$ $I_C = 5.0\text{A}_{dc}$, $V_{CE} = 2.0\text{V}_{dc}$	h_{FE}	60 60 40	240	
Collector-Emitter Saturation Voltage $I_C = 2.0\text{A}_{dc}$, $I_B = 0.2\text{A}_{dc}$ $I_C = 5.0\text{A}_{dc}$, $I_B = 0.5\text{A}_{dc}$	$V_{CE(sat)}$		0.7 1.2	Vdc
Base-Emitter Saturation Voltage $I_C = 2.0\text{A}_{dc}$, $I_B = 0.2\text{A}_{dc}$ $I_C = 5.0\text{A}_{dc}$, $I_B = 0.5\text{A}_{dc}$	$V_{BE(sat)}$		1.2 1.8	Vdc

DYNAMIC CHARACTERISTICS

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Magnitude of Common Emitter Small-Signal Short-Circuit Forward Current Transfer Ratio $I_C = 0.5\text{A}_{dc}$, $V_{CE} = 10\text{V}_{dc}$, $f = 10\text{MHz}$	$ h_{fe} $	3.0	15	
Output Capacitance $V_{CB} = 10\text{V}_{dc}$, $I_E = 0$, $100\text{kHz} \leq f \leq 1.0\text{MHz}$	C_{obo}		250	pF
Input Capacitance $V_{BE} = 2.0\text{V}_{dc}$, $I_C = 0$, $100\text{kHz} \leq f \leq 1.0\text{MHz}$	C_{ibo}		1,000	pF

SAFE OPERATING AREA

DC Tests

$T_C = +25^\circ\text{C}$, 1 Cycle, $t \geq 0.5\text{s}$

Test 1

$V_{CE} = 2.0\text{V}_{dc}$, $I_C = 5.0\text{A}_{dc}$

Test 2

$V_{CE} = 5.0\text{V}_{dc}$, $I_C = 2.0\text{A}_{dc}$

Test 3

$V_{CE} = 90\text{V}_{dc}$, $I_C = 55\text{mA}_{dc}$

(3) Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$